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## **LED ARRAY**

**LA10B/7G3A-1**

## **DATA SHEET**

DOC. NO : QW0905- LA10B/7G3A-1

REV. : B

DATE : 23 - Nov - 2004



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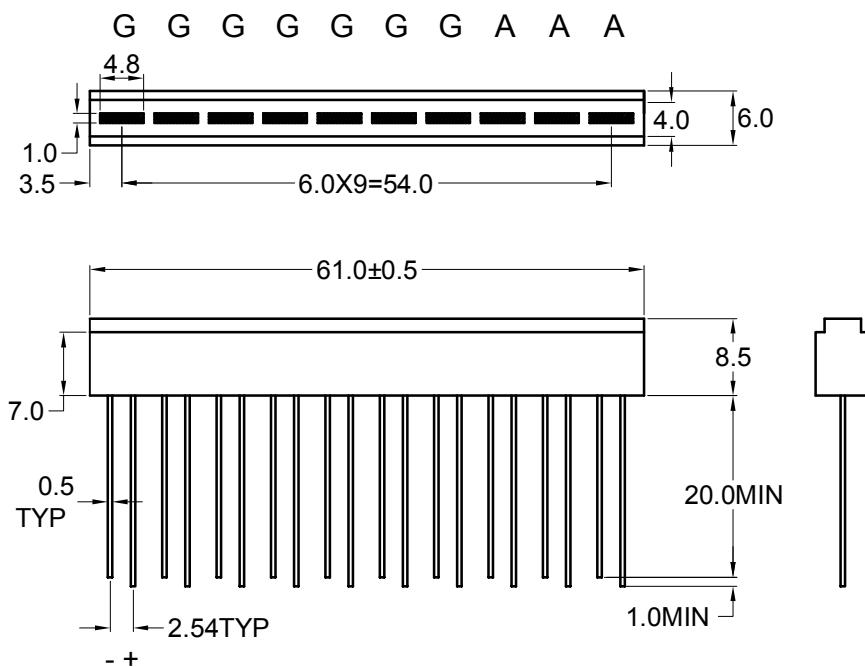
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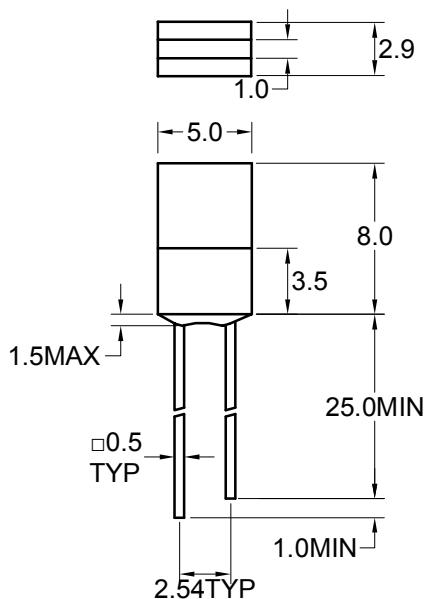
PART NO. LA10B/7G3A-1

Page 1/5

## Package Dimensions



LG7130  
LA7130



Note : 1.All dimension are in millimeter tolerance is ±0.25mm unless otherwise noted.  
2.Specifications are subject to change without notice.



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PART NO. LA10B/7G3A-1

Page 2/5

## Absolute Maximum Ratings at Ta=25

Parameter	Symbol	Ratings		UNIT
		G	Y-A	
Forward Current	I <sub>F</sub>	30	20	mA
Peak Forward Current Duty 1/10@10KHz	I <sub>FP</sub>	120	80	mA
Power Dissipation	P <sub>D</sub>	100	60	mW
Reverse Current @5V	I <sub>r</sub>	10		μ A
Operating Temperature	T <sub>opr</sub>	-40 ~ +85		
Storage Temperature	T <sub>stg</sub>	-40 ~ +100		
Soldering Temperature	T <sub>sol</sub>	Max 260 for 5 sec Max (2mm from body)		

## Typical Electrical &amp; Optical Characteristics (Ta=25 )

PART NO	MATERIAL	COLOR		Peak wave length Pnm	Dominant wave length Dnm	Spectral halfwidth nm	Forward voltage @20mA(V)		Luminous intensity @10mA(mcd)		Viewing angle 2 1/2 (deg)
		Emitted	Lens				Min.	Max.	Min.	Typ.	
LA10B/7G3A-1	GaP	Green	Green Diffused	565	--	30	1.7	2.6	4.5	8.0	74
	GaAsP/GaP	Yellow	Orange Diffused	--	592	35	1.7	2.6	3.0	5.5	74

Note : 1.The forward voltage data did not including ±0.1V testing tolerance.

2. The luminous intensity data did not including ±15% testing tolerance.



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PART NO. LA10B/7G3A-1

Page 3/5

## Typical Electro-Optical Characteristics Curve

G CHIP

Fig.1 Forward current vs. Forward Voltage

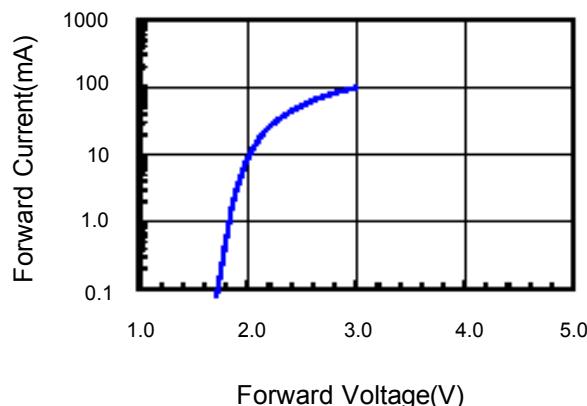


Fig.2 Relative Intensity vs. Forward Current

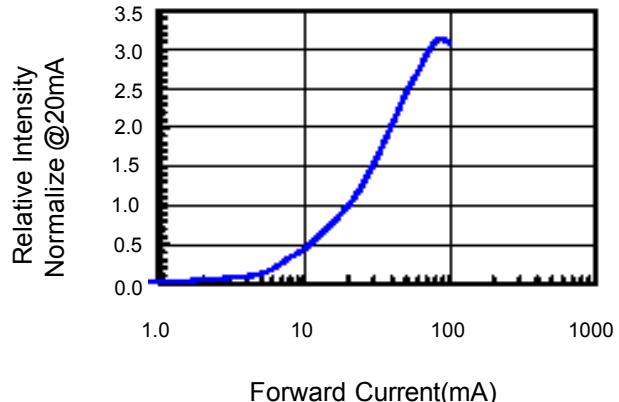


Fig.3 Forward Voltage vs. Temperature

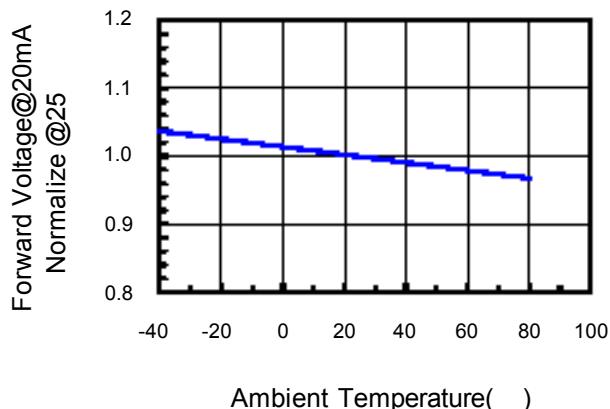


Fig.4 Relative Intensity vs. Temperature

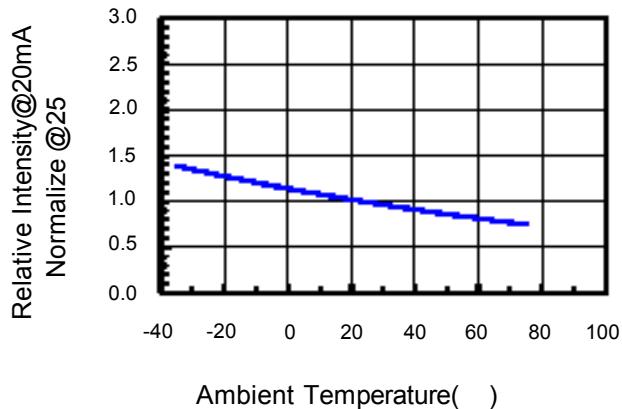


Fig.5 Relative Intensity vs. Wavelength

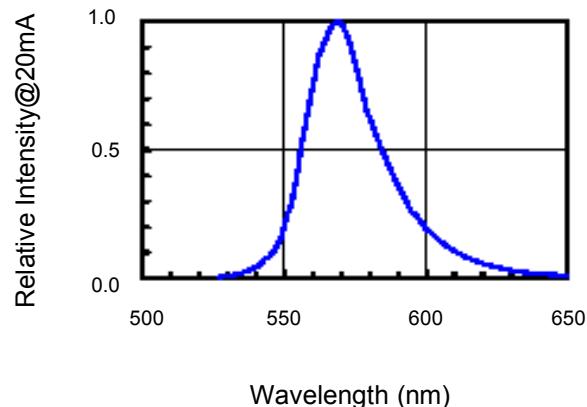


Fig.6 Directive Radiation



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PART NO. LA10B/7G3A-1

Page 4/5

## Typical Electro-Optical Characteristics Curve

Y-A CHIP

Fig.1 Forward current vs. Forward Voltage

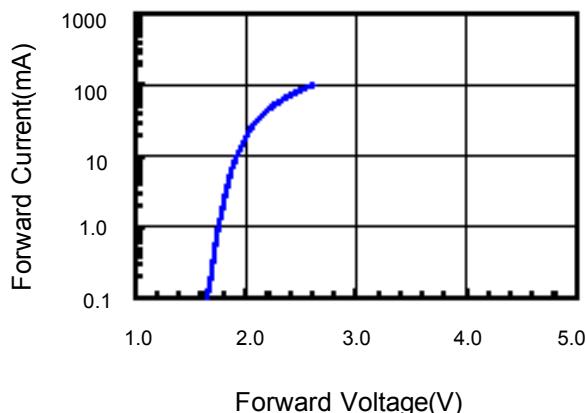


Fig.2 Relative Intensity vs. Forward Current

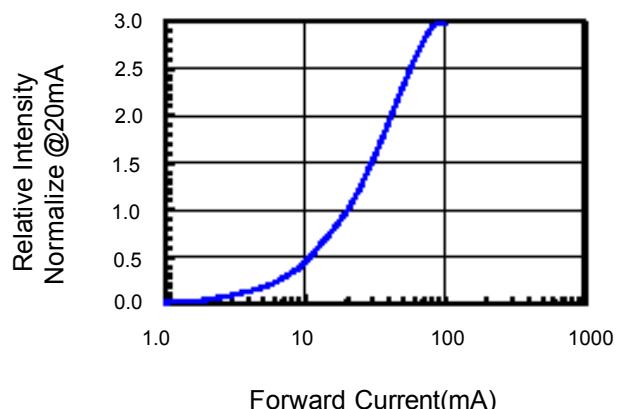


Fig.3 Forward Voltage vs. Temperature

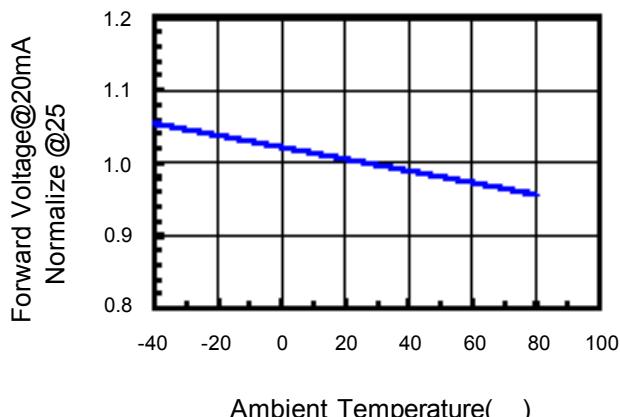


Fig.4 Relative Intensity vs. Temperature

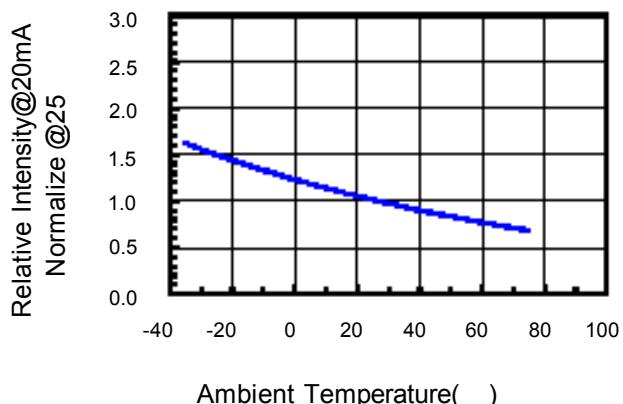
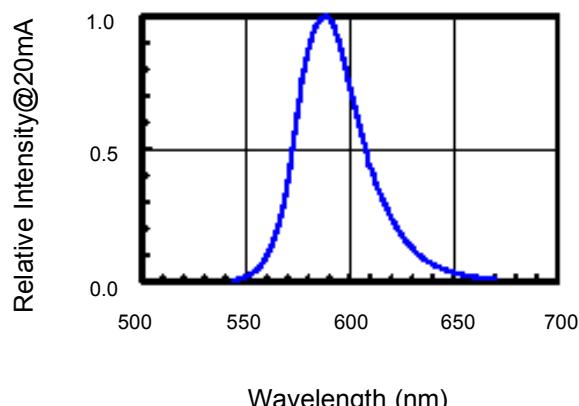


Fig.5 Relative Intensity vs. Wavelength





## Reliability Test:

Test Item	Test Condition	Description	Reference Standard
Operating Life Test	1.Under Room Temperature 2.If=20mA 3.t=1000 hrs (-24hrs, +72hrs)	This test is conducted for the purpose of determining the resistance of a part in electrical and thermal stressed.	MIL-STD-750: 1026 MIL-STD-883: 1005 JIS C 7021: B-1
High Temperature Storage Test	1.Ta=105 ±5 2.t=1000 hrs (-24hrs, +72hrs)	The purpose of this is the resistance of the device which is laid under condition of high temperature for hours.	MIL-STD-883:1008 JIS C 7021: B-10
Low Temperature Storage Test	1.Ta=-40 ±5 2.t=1000 hrs (-24hrs, +72hrs)	The purpose of this is the resistance of the device which is laid under condition of low temperature for hours.	JIS C 7021: B-12
High Temperature High Humidity Test	1.Ta=65 ±5 2.RH=90 %~95 % 3.t=240hrs ±2hrs	The purpose of this test is the resistance of the device under tropical for hours.	MIL-STD-202:103B JIS C 7021: B-11
Thermal Shock Test	1.Ta=105 ±5 &-40 ±5 (10min) (10min) 2.total 10 cycles	The purpose of this is the resistance of the device to sudden extreme changes in high and low temperature.	MIL-STD-202: 107D MIL-STD-750: 1051 MIL-STD-883: 1011
Solder Resistance Test	1.T.Sol=260 ±5 2.Dwell time= 10 ±1sec.	This test intended to determine the thermal characteristic resistance of the device to sudden exposures at extreme changes in temperature when soldering the lead wire.	MIL-STD-202: 210A MIL-STD-750: 2031 JIS C 7021: A-1
Solderability Test	1.T.Sol=230 ±5 2.Dwell time=5 ±1sec	This test intended to see soldering well performed or not.	MIL-STD-202: 208D MIL-STD-750: 2026 MIL-STD-883: 2003 JIS C 7021: A-2